


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/539,872	BALAKRISHNAN ET AL.	
	Examiner	Art Unit	
	Kimbinh T. Nguyen	2628	

SEARCHED			
Class	Subclass	Date	Examiner
264	409	8/22/2006	KN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST: text search	8/22/2006	KN
NPL: ACM, IEEE, GOOGLE	8/22/2006	KN